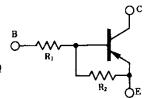


# COMPOUND TRANSISTOR BN1A3Q

# on-chip resistor PNP silicon epitaxial transistor For mid-speed switching

#### **FEATURES**

• On-chip bias resistor (R<sub>1</sub> = 1.0 k $\Omega$ , R<sub>2</sub> = 10 k $\Omega$ )



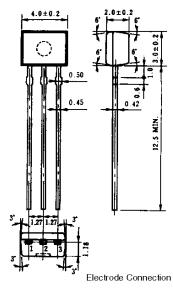
• Complementary transistor with BA1A3Q

#### ABSOLUTE MAXIMUM RATINGS (Ta = 25°C)

Parameter	Symbol	Ratings	Unit
Collector to base voltage	Vсво	-60	V
Collector to emitter voltage	Vceo	<b>–50</b>	V
Emitter to base voltage	VEBO	<b>-</b> 5	V
Collector current (DC)	Ic(DC)	-100	mA
Collector current (Pulse)	Ic(pulse) *	-200	mA
Total power dissipation	Рт	250	mW
Junction temperature	Tj	150	°C
Storage temperature	T <sub>stg</sub>	-55 to +150	°C

<sup>\*</sup> PW  $\leq$  10 ms, duty cycle  $\leq$  50 %

## PACKAGE DRAWING (UNIT: mm)



1. Emitter

3. Base

2. Collector

**ELECTRICAL CHARACTERISTICS (Ta = 25°C)** 

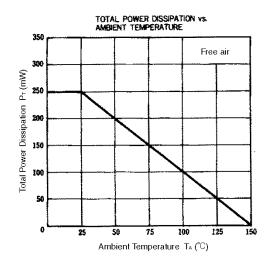
Parameter	Symbol	Conditions	MIN.	TYP.	MAX.	Unit
Collector cutoff current	Ісво	$V_{CB} = -50 \text{ V}, I_E = 0$			-100	nA
DC current gain	h <sub>FE1</sub> **	$V_{CE} = -5.0 \text{ V}, \text{ Ic} = -5.0 \text{ mA}$	35	60	80	ı
DC current gain	hFE2 **	$V_{CE} = -5.0 \text{ V}, \text{ Ic} = -50 \text{ mA}$	80	200		ı
Collector saturation voltage	V <sub>CE(sat)</sub> **	$I_C = -5.0 \text{ mA}, I_B = -0.25 \text{ mA}$		-0.04	-0.2	٧
Low level input voltage	VIL **	$V_{CE} = -5.0 \text{ V}, \text{ IB} = -100 \ \mu\text{A}$		-0.7	-0.5	٧
High level input voltage	V <sub>IH</sub> **	$V_{CE} = -0.2 \text{ V}, \text{ Ic} = -5.0 \text{ mA}$	-2.0	-1.0		٧
Input resistance	R <sub>1</sub>		0.7	1.0	1.3	kΩ
E-to-B resistance	R <sub>2</sub>		7	10	13	kΩ
Turn-on time	ton	$Vcc = -5 \text{ V}, \text{ RL} = 1 \text{ k}\Omega$			0.2	μs
Storage time	tstg	$V_1 = -5 \text{ V}, \text{ PW} = 2 \mu \text{s}$			5.0	μs
Turn-off time	toff	duty cycle≤2 %			6.0	μs

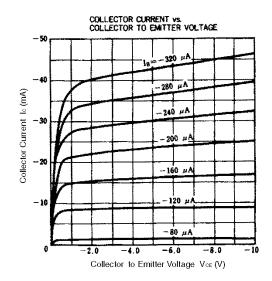
<sup>\*\*</sup> PW  $\leq$  350  $\mu$ s, duty cycle  $\leq$  2 %

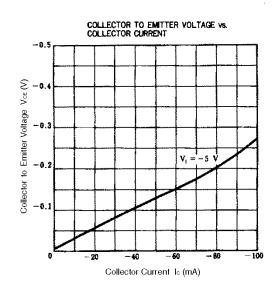
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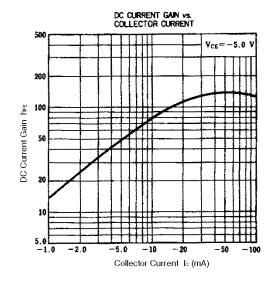


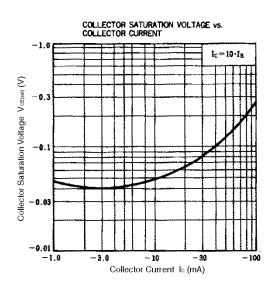
### TYPICAL CHARACTERISTICS (Ta = 25°C)

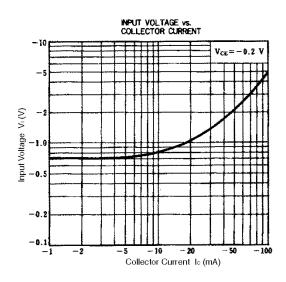


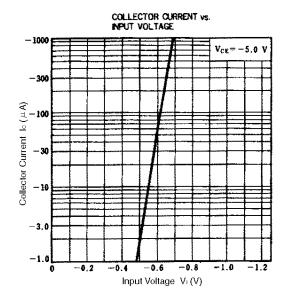


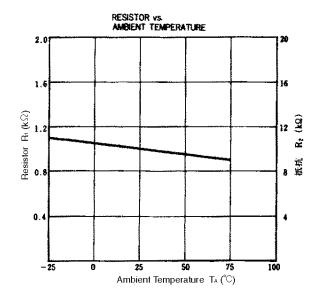












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